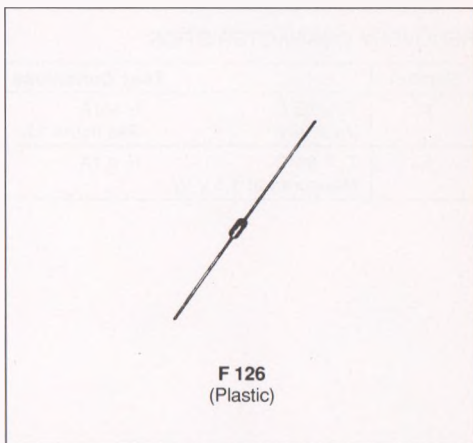


FAST RECOVERY RECTIFIER DIODES

- VERY FAST FORWARD AND REVERSE RECOVERY DIODES



SUITED FOR

- SWITCHING POWER TRANSISTORS DRIVER CIRCUITS (SERIES DIODES IN ANTISATURATION CLAMP SPEED UP DIODE IN DISCRETE DARLINGTON...)
- THYRISTORS GATE DRIVER CIRCUITS
- HIGH FREQUENCY RECTIFICATION

ABSOLUTE RATINGS (limiting values)

Symbol	Parameter		Value	Unit
I_{FRM}	Repetitive Peak Forward Current	$t_p \leq 20\mu s$	20	A
$I_{F(AV)}$	Average Forward Current	$T_a = 25^\circ C$ $\delta = 0.5$	1	A
I_{FSM}	Surge non Repetitive Forward Current	$t_p = 10ms$ Sinusoidal	20	A
P_{Tot}	Power Dissipation*	$T_a = 25^\circ C$	1.7	W
T_{stg} T_j	Storage and Junction Temperature Range		- 40 to 125	$^\circ C$
T_L	Maximum Lead Temperature for Soldering during 10s at 4mm from Case		230	$^\circ C$

Symbol	Parameter	PLQ 08	PLQ 1	Unit
V_{RRM}	Repetitive Peak Reverse Voltage	80	100	V
V_{RSM}	Non Repetitive Peak Reverse Voltage	80	100	V

THERMAL RESISTANCE

Symbol	Parameter	Value	Unit
$R_{th(j-a)}$	Junction-ambient*	60	$^\circ C/W$

* On infinite heatsink with 10mm lead length.

ELECTRICAL CHARACTERISTICS

STATIC CHARACTERISTICS

Symbol	Test Conditions		Min.	Typ.	Max.	Unit
I_R	$T_j = 25^\circ\text{C}$	$V_R = V_{RRM}$			10	μA
	$T_j = 100^\circ\text{C}$				0.5	mA
V_F	$T_j = 25^\circ\text{C}$	$I_F = 1\text{A}$			1.1	V

RECOVERY CHARACTERISTICS

Symbol	Test Conditions			Min.	Typ.	Max.	Unit
t_{rr}	$T_j = 25^\circ\text{C}$ $V_R = 30\text{V}$	$I_F = 1\text{A}$ See figure 12	$di_F/dt = -50\text{A}/\mu\text{s}$			50	ns
t_{rr}	$T_j = 25^\circ\text{C}$ Measured at $1.1 \times V_F$	$I_F = 1\text{A}$	$t_r = 20\text{ns}$			50	ns

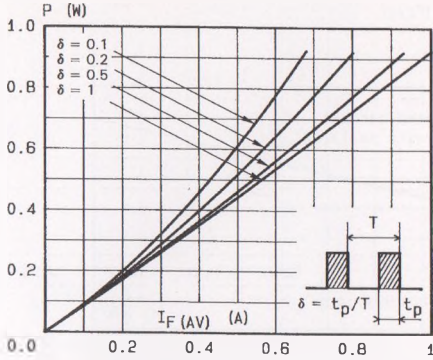


FIGURE 1 : Power losses versus average current.

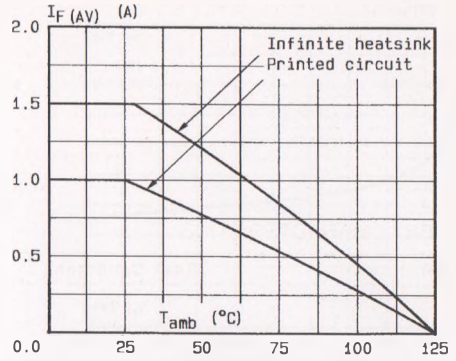


FIGURE 2 : Allowable DC current versus ambient temperature.

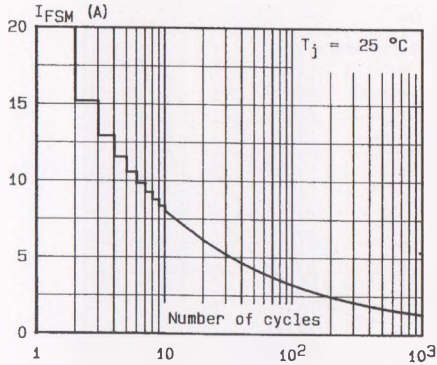


FIGURE 3 : Non repetitive surge peak current versus number of cycles.

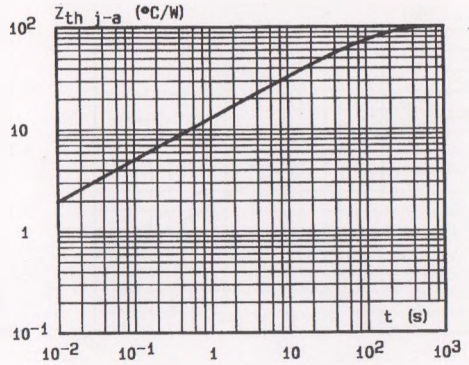


Fig.4 - Transient thermal impedance junction-ambient Printed circuit versus pulse duration (L = 10 mm).

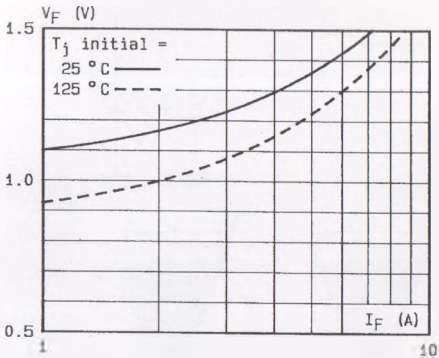


FIGURE 5 : Voltage drop versus forward current.

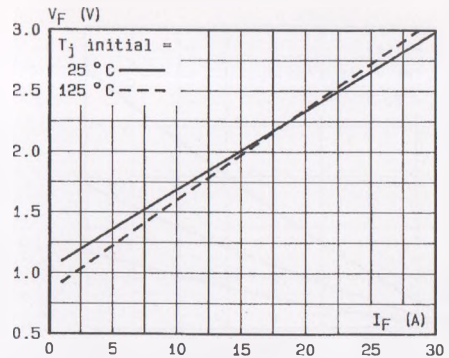


FIGURE 8 : Voltage drop versus forward current.

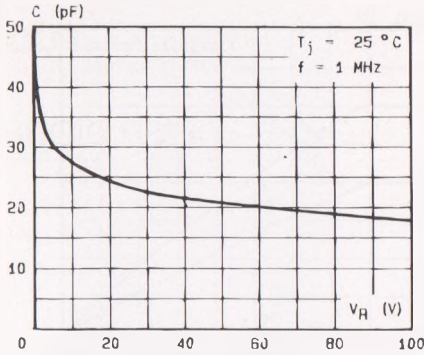


FIGURE 7 : Capacitance versus reverse voltage applied.

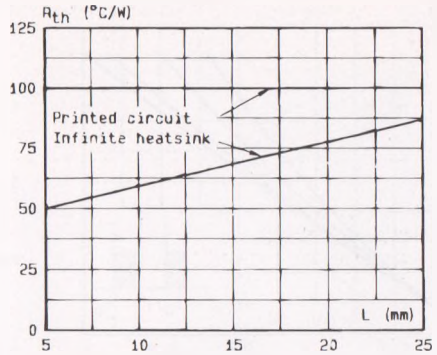


FIGURE 8 : Thermal resistance junction-ambient versus lead length.

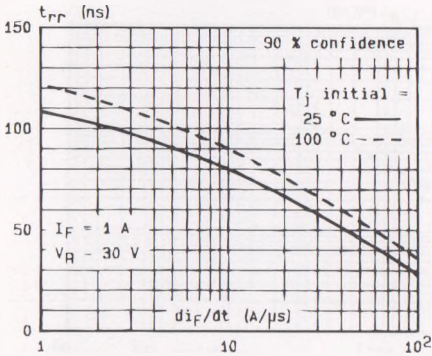


FIGURE 9 : Recovery time versus di_F/dt .

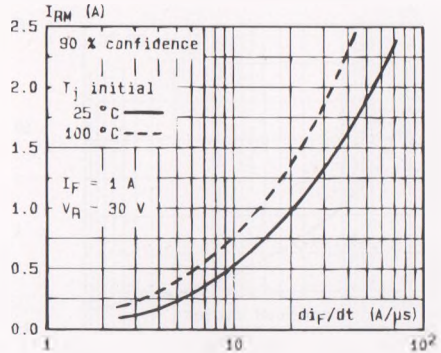


FIGURE 10 : Peak reverse current versus di_F/dt .

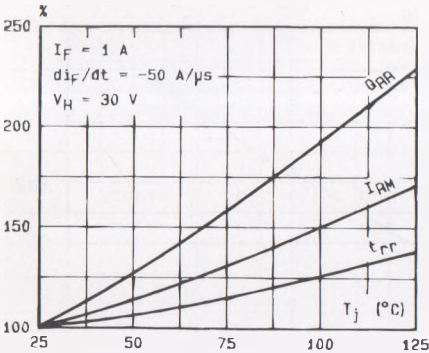


FIGURE 11 : Dynamic parameters versus junction temperature.

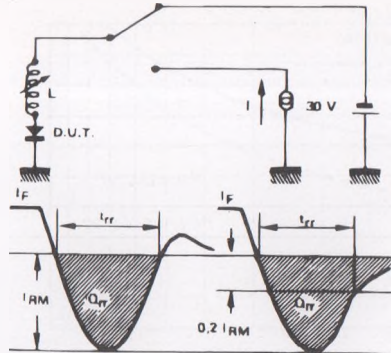


FIGURE 12 : Measurement of t_{rr} (fig.8) and I_{RM} (fig.10).